

Issue Classification 	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10751562	LEE ET AL.
Examiner	Art Unit	
	CHIA-WEI A CHEN	2622

ORIGINAL					INTERNATIONAL CLASSIFICATION													
CLASS		SUBCLASS			CLAIMED				NON-CLAIMED									
348			308			H	0	4	N	3 / 14 (2006.01.01)			H	0	1	L	27 / 00 (2006.01.01)	
CROSS REFERENCE(S)					H	0	4	N	5 / 335 (2006.01.01)									
CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)																	
348	294	310																
250	208.1																	

/CHIA-WEI A CHEN/ (Assistant Examiner)	5/9/2008 (Date)		Total Claims Allowed: 38
/NgocYen T. VU/ (Primary Examiner)	5/12/08 (Date)	O.G. Print Claim(s) 1	O.G. Print Figure 6